



N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)}	I _D T _A = +25°C
60V	$85m\Omega @ V_{GS} = 10V$	4.1A
	110mΩ @ V _{GS} = 4.5V	3.6A

Description

This new generation MOSFET is designed to minimize the on-state resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- Power Management Functions
- Backlighting

Features

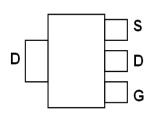
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

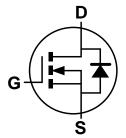
- Case: SOT89
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Finish Annealed over Copper Lead Frame. Solderable per MIL-STD-202, Method 208 (23)
- Weight: 0.052 grams (Approximate)







Pin-Out Top



Equivalent Circuit

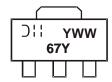
Ordering Information (Note 4)

Part Number	Case	Quantity per Reel
DMN6070SY-13	SOT89	2,500

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



);; = Manufacturer's Marking
67Y= Product Type Marking Code
YWW = Date Code Marking
Y = Year (ex: 7 = 2017)
WW = Week (01 to 53)



Maximum Ratings $(@T_A = +25^{\circ}C, \text{ unless otherwise specified.})$

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V_{DSS}	60	V
Gate-Source Voltage			V_{GSS}	±20	V
Continuous Drain Current (Note 6) V _{GS} = 10V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	4.1 3.3	А
Pulsed Drain Current (10µs Pulse, Duty Cycle ≦1%)	I _{DM}	15	А		
Maximum Body Diode Continuous Current (Note 6)			Is	2.5	А
Pulsed Body Diode Current (10µs Pulse, Duty Cycle ≦1%)			I _{SM}	15	А
Avalanche Current, L=0.1mH (Note 7)			I _{AS}	11	А
Avalanche Energy, L=0.1mH (Note 7)			Eas	6	mJ

Thermal Characteristics

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 5)	T _A = +25°C	P_{D}	0.9	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	6	122	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	72	°C/W
Total Power Dissipation (Note 6)	$T_A = +25^{\circ}C$	P_{D}	2.1	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	6	58	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	34	°C/W
Thermal Resistance, Junction to Case (Note 6)	$R_{ heta JC}$	12	°C/W	
Operating and Storage Temperature Range	$T_{J_i} T_{STG}$	-55 to +150	°C	

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

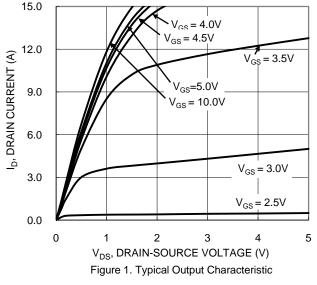
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV _{DSS}	60	_	_	V	$I_D = 250 \mu A$, $V_{GS} = 0 V$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μΑ	V _{DS} = 60V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 16V$, $V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(TH)}	1.0		3.0	V	$I_D=250\mu A,\ V_{DS}=V_{GS}$	
Static Drain-Source On-Resistance			70	85	mΩ	V_{GS} = 10V, I_{D} = 2.5A	
Static Drain-Source On-Resistance	R _{DS(ON)}		76	110	mtz	$V_{GS} = 4.5V, I_D = 1.5A$	
Diode Forward Voltage	V_{SD}	_	0.75	1.2	V	I _S = 12A, V _{GS} = 0V	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C _{iss}		588	_		V _{DS} = 30V, V _{GS} = 0V f= 1MHz	
Output Capacitance	Coss		26.5	_	pF		
Reverse Transfer Capacitance	C _{rss}		20	_			
Gate Resistance	R_g		1.5	_	Ω	Vgs= 0V, Vds= 0V, f=1MHz,	
Total Gate Charge (V _{GS} = 4.5V)	Q_g	_	5.6	_			
Total Gate Charge (V _{GS} = 10V)	Qg	_	12.3	_	nC Vps= 30V lp= 3A		
Gate-Source Charge	Q_{gs}	_	1.7	_	IIC	V _{DS} = 30V, I _D = 3A	
Gate-Drain Charge	Q_{qd}	_	1.9	_			
Turn-On Delay Time	t _{D(ON)}	_	3.5	_		V_{DD} = 30V, V_{GS} = 10V $R_L \cong 50\Omega$, $R_g \cong 20\Omega$	
Turn-On Rise Time	t _R	_	4.1	_			
Turn-Off Delay Time	t _{D(OFF)}	_	35	_	ns		
Turn-Off Fall Time	t _F	_	11	_			
Body Diode Reverse Recovery Time	t _{RR}	_	18	_	ns	I _S = 12A, di/dt = 100A/μs	
Body Diode Reverse Recovery Charge	Q _{RR}	_	12	_	nC	I _S = 12A, di/dt = 100A/μs	

5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.

^{6.} Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate.

 ^{7.} I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep T_J = +25°C.
 8. Short duration pulse test used to minimize self-heating effect.
 9. Guaranteed by design. Not subject to product testing.





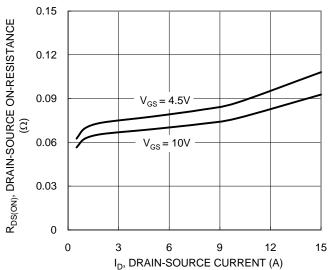


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

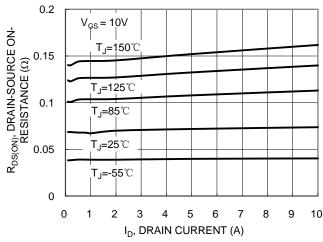


Figure 5. Typical On-Resistance vs. Drain Current and Temperature

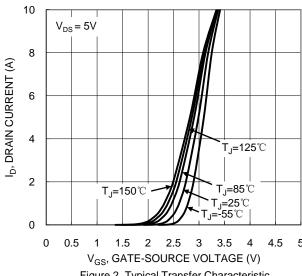


Figure 2. Typical Transfer Characteristic

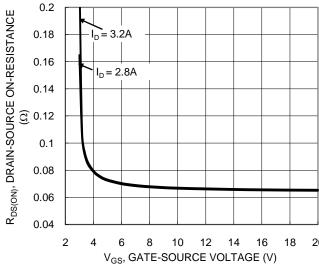


Figure 4. Typical Transfer Characteristic

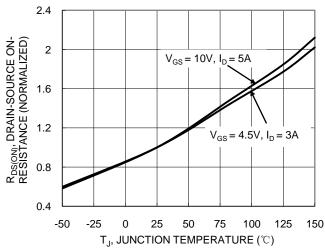
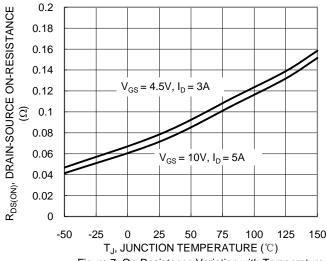
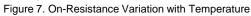
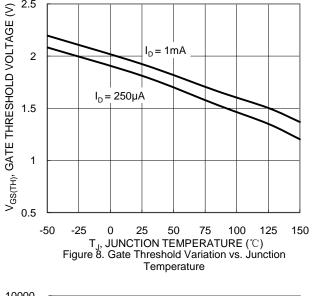


Figure 6. On-Resistance Variation with Temperature









2.5

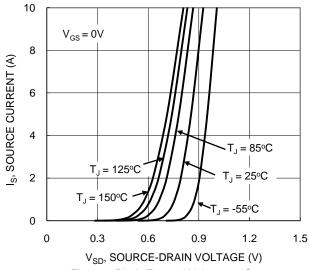
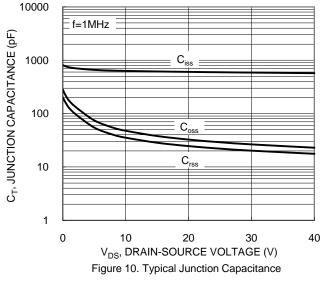
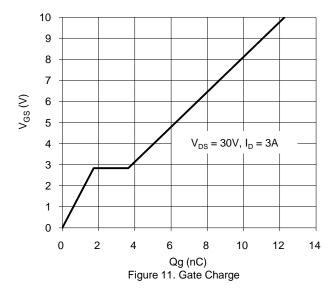
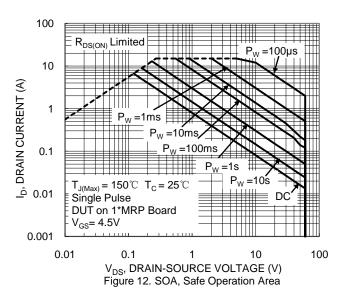


Figure 9. Diode Forward Voltage vs. Current









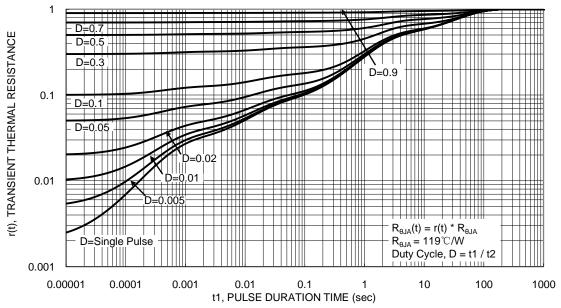
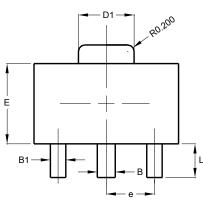


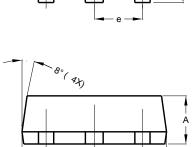
Figure 13. Transient Thermal Resistance

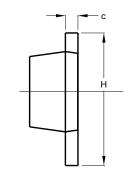


Package Outline Dimensions

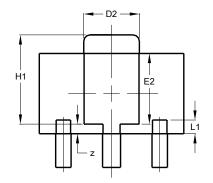
Please see http://www.diodes.com/package-outlines.html for the latest version.







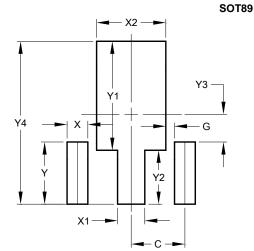
SOT89



0.0700						
SOT89						
Dim	Min	Max	Тур			
Α	1.40	1.60	1.50			
В	0.50	0.62	0.56			
B1	0.42	0.54	0.48			
С	0.35	0.43	0.38			
D	4.40	4.60	4.50			
D1	1.62	1.83	1.733			
D2	1.61	1.81	1.71			
Е	2.40	2.60	2.50			
E2	2.05	2.35	2.20			
е	-	-	1.50			
Н	3.95	4.25	4.10			
H1	2.63	2.93	2.78			
Ĺ	0.90	1.20	1.05			
L1	0.327	0.527	0.427			
Z	0.20	0.40	0.30			
All Dimensions in mm						

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)		
С	1.500		
G	0.244		
Х	0.580		
X1	0.760		
X2	1.933		
Υ	1.730		
Y1	3.030		
Y2	1.500		
Y3	0.770		
Y4	4.530		



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